Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/027,657	MEYER ET AL.	
Examiner	Art Unit	
Jia W. Lu	2611	

	SEARCHED				
Class	Subclass	Date	Examiner		
375	347	5/2/2006	JL		

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
347	5/2/2006	JL		
		-		
:				
	Subclass	Subclass Date		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
ALL EAST DATABASES	5/2/2006	JL	
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